Notice of References Cited

Application/Control No. Applicant(s)/Patent Under Reexamination 10/587,727 TIMMERMANS, DANIEL Examiner Art Unit Page 1 of 1 SYED ZIA 2431

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,419,159 B1	07-2002	Odinak, Gilad	235/492
*	В	US-2003/0194086 A1	10-2003	Lambert, Robert J.	380/44
*	O	US-6,654,884 B2	11-2003	Jaffe et al.	713/168
*	D	US-6,748,535 B1	06-2004	Ryan et al.	713/189
*	Е	US-6,766,455 B1	07-2004	Ryan, Jr., Frederick W.	713/189
*	F	US-2005/0055596 A1	03-2005	Abe et al.	713/500
*	G	US-2005/0089060 A1	04-2005	Vergnes, Alain	370/463
*	н	US-2005/0134319 A1	06-2005	Bock, Holger	326/104
*	-	US-2005/0147243 A1	07-2005	Baek, Yoo-Jin	380/028
*	7	US-2006/0261858 A1	11-2006	Manfred, Roth	326/105
*	К	US-2009/0222672 A1	09-2009	Clarke et al.	713/189
*	L	US-7,613,763 B2	11-2009	Elbe et al.	708/710
*	М	US-7,757,083 B2	07-2010	Devadas et al.	713/168

FOREIGN PATENT DOCUMENTS

*		Country Code-Number-Kind Code	MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

		HON ALEN DOGINENTO
•		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	IEEE Transaction; "High Level Side-Channel Attack Modelling and Simulation forSecurity-Critical Systems on Chips", F.Menichelli et al; 2008
	٧	
	w	
	х	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.